# **MOSFET** - Power, DUAL COOL® N-Channel, **DFN8 5x6** 40 V, 0.87 mΩ, 310 A

# NTMFSCOD9N04C

#### **Features**

- Advanced Dual-sided Cooled Packaging
- Small Footprint (5x6 mm) for Compact Design
- Ulra Low R<sub>DS(on)</sub> to Minimize Conduction Losses
- Low Q<sub>G</sub> and Capacitance to Minimize Driver Losses
- These Devices are Pb-Free and are RoHS Compliant
- MSL1 Robust Packaging Design

## MAXIMUM RATINGS (T<sub>J</sub> = 25°C unless otherwise noted)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			$V_{DSS}$	40	V
Gate-to-Source Voltage			$V_{GS}$	±20	V
Continuous Drain Current R <sub>θJC</sub> (Note 2)	Steady State	T <sub>C</sub> = 25°C	I <sub>D</sub>	313	Α
Power Dissipation R <sub>0</sub> JC (Note 2)			P <sub>D</sub>	166	W
Continuous Drain Current $R_{\theta,JA}$ (Notes 1, 2)	Steady State	T <sub>A</sub> = 25°C	I <sub>D</sub>	48.9	Α
Power Dissipation R <sub>θJA</sub> (Notes 1, 2)			P <sub>D</sub>	4.1	W
Pulsed Drain Current	$T_A = 25^{\circ}C, t_p = 10 \mu s$		I <sub>DM</sub>	900	Α
Operating Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>stg</sub>	-55 to +175	°C	
Source Current (Body Diode)		Is	158	Α	
Single Pulse Drain-to-Source Avalanche Energy (I <sub>L(pk)</sub> = 34 A)		E <sub>AS</sub>	578	mJ	
Lead Temperature Soldering Reflow for Soldering Purposes (1/8" from case for 10 s)		TL	300	°C	

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

## THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case (Bottom)- Steady State (Note 2)	$R_{\theta JC}$	0.9	°C/W
Junction-to-Case (Top) - Steady State (Note 2)	$R_{\theta JC}$	1.4	
Junction-to-Ambient - Steady State (Note 2)	$R_{\theta JA}$	37	

- 1. Surface-mounted on FR4 board using a 1 in<sup>2</sup> pad size, 1 oz Cu pad.
- 2. The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.

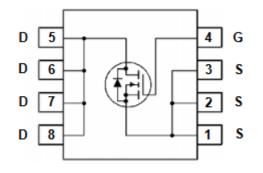


## ON Semiconductor®

#### www.onsemi.com

V <sub>(BR)DSS</sub>	R <sub>DS(ON)</sub> MAX	I <sub>D</sub> MAX
40 V	0.87 m $\Omega$ @ 10 V	310 A

#### **N-Channel MOSFET**





#### MARKING DIAGRAM



410NDC = Specific Device Code

= Assembly Location Α Υ

= Year

W = Work Week

ZZ = Lot Traceability

## **ORDERING INFORMATION**

See detailed ordering and shipping information on page 5 of this data sheet.

## **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = 25°C unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS							
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		40			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> / T <sub>J</sub>	I <sub>D</sub> = 250 μA, ref to 25°C			5		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 40 V	$T_J = 25^{\circ}C$			10	μΑ
			T <sub>J</sub> = 125°C			100	
Gate-to-Source Leakage Current	I <sub>GSS</sub>	V <sub>DS</sub> = 0 V, V <sub>GS</sub> = +20 V				100	nA
ON CHARACTERISTICS (Note 3)							
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}, I_D =$	= 250 μA	2.5		3.5	V
Negative Threshold Temperature Coefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>	I <sub>D</sub> = 250 μA, ref	to 25°C		-8.6		mV/°C
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V	I <sub>D</sub> = 50 A		0.69	0.87	mΩ
CHARGES & CAPACITANCES							
Input Capacitance	C <sub>ISS</sub>	V <sub>GS</sub> = 0 V, f = 1 MHz	z, V <sub>DS</sub> = 25 V		6100		pF
Output Capacitance	C <sub>OSS</sub>				3400		
Reverse Transfer Capacitance	C <sub>RSS</sub>				70		
Total Gate Charge	Q <sub>G(TOT)</sub>	V <sub>GS</sub> = 10 V, V <sub>DS</sub> = 32 V; I <sub>D</sub> = 50 A			86		
Gate-to-Source Charge	$Q_{GS}$				28		
Gate-to-Drain Charge	$Q_{GD}$				14		
Plateau Voltage	$V_{GP}$				4.9		V
SWITCHING CHARACTERISTICS (Note 3)							•
Turn-On Delay Time	t <sub>d(ON)</sub>	$V_{GS} = 10 \text{ V}, V_{DS} = 32 \text{ V},$ $I_D = 50 \text{ A}, R_G = 2.5 \Omega$			54		ns
Rise Time	t <sub>r</sub>	$I_D = 50 \text{ A}, R_G =$	= 2.5 Ω		160		1
Turn-Off Delay Time	t <sub>d(OFF)</sub>				220		1
Fall Time	t <sub>f</sub>				170		
DRAIN-SOURCE DIODE CHARACTERISTICS	,				•		•
Forward Diode Voltage	V <sub>SD</sub>	$V_{GS} = 0 V$ , $I_S = TBD A$	T <sub>J</sub> = 25°C		0.8	1.2	V
			T <sub>J</sub> = 125°C		0.65		
Reverse Recovery Time	t <sub>RR</sub>	$V_{GS}$ = 0 V, $dI_S/dt$ = 100 A/ $\mu$ s, $I_S$ = 50 A			91		ns
Charge Time	t <sub>a</sub>				42		1
Discharge Time	t <sub>b</sub>				49		
Reverse Recovery Charge	Q <sub>RR</sub>				159		nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

3. Switching characteristics are independent of operating junction temperatures.

#### **TYPICAL CHARACTERISTICS**

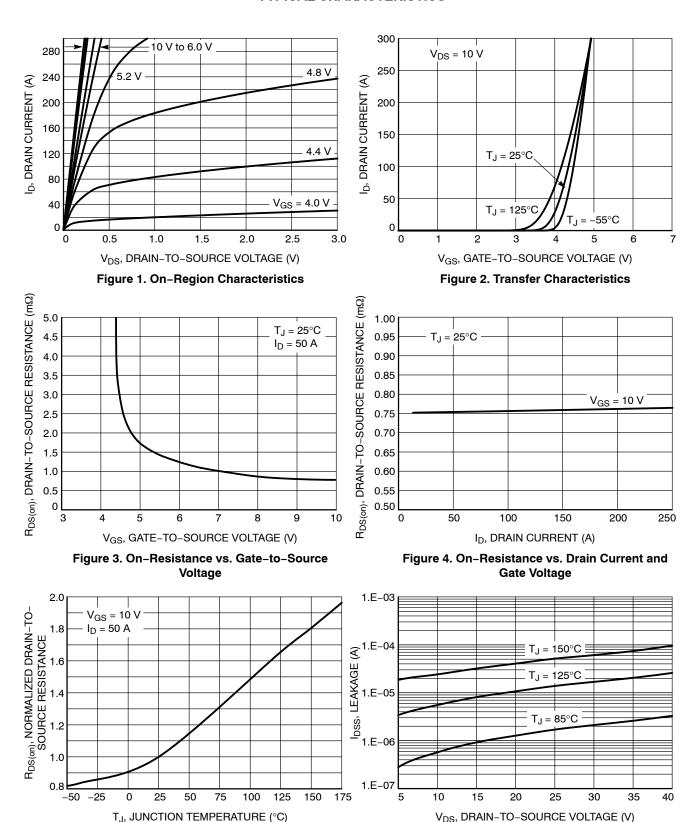


Figure 6. Drain-to-Source Leakage Current

vs. Voltage

Figure 5. On-Resistance Variation with

**Temperature** 

#### **TYPICAL CHARACTERISTICS**

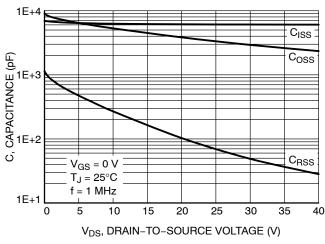


Figure 7. Capacitance Variation

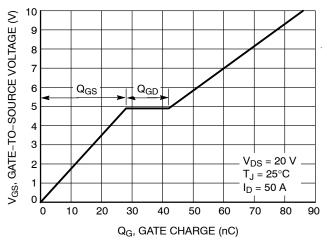


Figure 8. Gate-to-Source Voltage vs. Charge

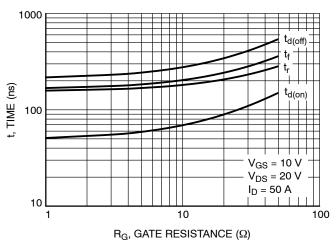


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

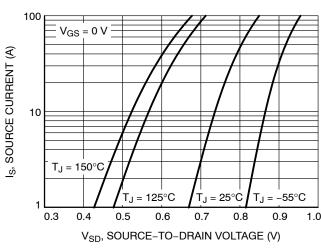


Figure 10. Diode Forward Voltage vs. Current

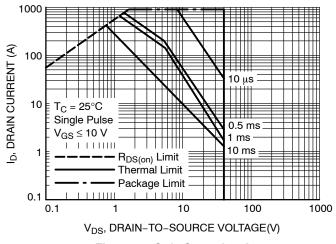


Figure 11. Safe Operating Area

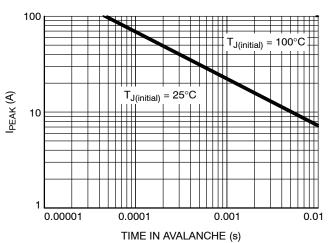


Figure 12. I<sub>PEAK</sub> vs. Time in Avalanche

#### **TYPICAL CHARACTERISTICS**

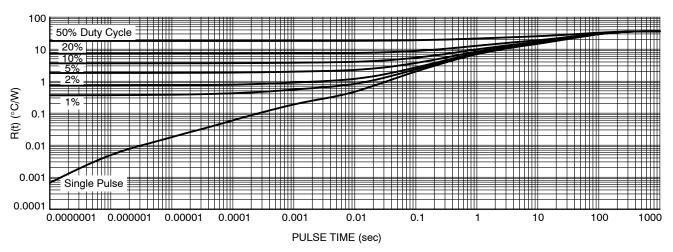


Figure 13. Thermal Characteristics

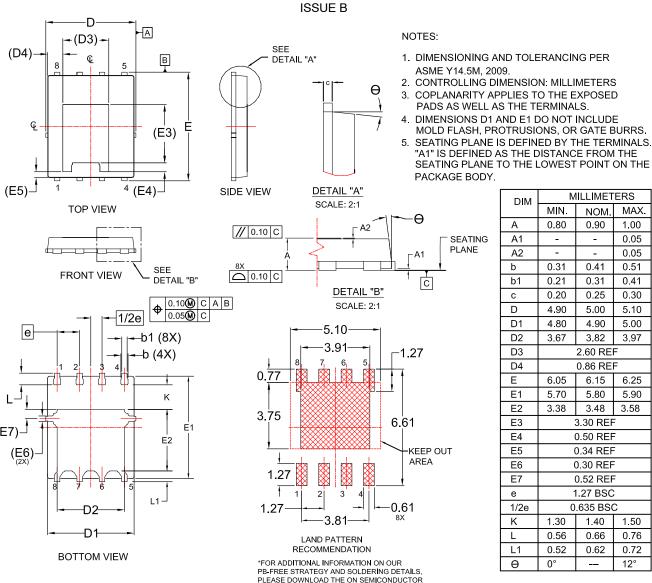
## **ORDERING INFORMATION**

Device	Device Marking	Package	Shipping <sup>†</sup>
NTMFSC0D9N04C	410NDC	DFN8 5x6 (Pb-Free/Halogen Free)	3000 / Tape & Reel

<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

#### PACKAGE DIMENSIONS

## DFN8 5.1x6.15, 1.27P CASE 506EG



0 11121		. 0	0111112		
DIM	MILLIMETERS				
	MIN.	NOM.	MAX.		
Α	0.80	0.90	1.00		
A1	-	-	0.05		
A2	-	-	0.05		
b	0.31	0.41	0.51		
b1	0.21	0.31	0.41		
С	0.20	0.25	0.30		
D	4.90	5.00	5.10		
D1	4.80	4.90	5.00		
D2	3.67	3.82	3.97		
D3	2.60 REF				
D4	0.86 REF				
E	6.05	6.15	6.25		
E1	5.70	5.80	5.90		
E2	3.38	3.48	3.58		
E3	3.30 REF				
E4	0.50 REF				
E5	0.34 REF				
E6	0.30 REF				

0.52 REF

1.27 BSC

0.635 BSC

1.40

0.66

0.62

1.50

0.76

0.72

12°

1.30

0.56

0.52

0°

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